

Notice of References Cited	Application/Control No. 10/516,672		Applicant(s)/Patent Under Reexamination SCHULZE-TRAUTMANN ET AL.	
	Examiner Randy Boyer		Art Unit 1797	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0199040	10-2004	Hoek et al.	585/664
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 200174969 A2	10-2001	WIPO	Wittenbrink et al.	
	O	EP 776959 A2	06-1997	EPO	Bertaux et al.	
	P	EP 668342 A1	08-1995	EPO	Eilers et al.	
	Q					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	W	
	X	

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